Removing XRF clutter with SmartLab®

Rigaku’s SmartLab® combines multiple X-ray detection systems in a single instrument to ensure the highest possible performance in a wide range of applications. The SmartLab® platform is now being outfitted with Rigaku’s new XRF detectors. These detector upgrades will increase the speed and efficiency of XRF analysis, providing scientists with the optimal tools to answer their questions. Many XRF papers are currently in press (issue 1610 May 2016). For more information about these papers, please visit the Rigaku Journal Article section.

Meetings

Join us at the Characterization Workshop PPXRD-14 (8-10 June 2016) in Copenhagen, Denmark, and the 9th International Conference on the Science and Technology of X-ray and Neutron Scattering, The Bridge (5-10 June 2016) in London, UK. The conference will include a special session on XRF, featuring presentations from members of the XRF team at Rigaku Corporation. For more information, please visit the Events section.

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